

MAX14783E

High-Speed 3.3V/5V RS-485/RS-422 Transceiver with $\pm 35\text{kV}$ HBM ESD Protection

General Description

The MAX14783E is a half-duplex RS-485/422 transceiver that operates at either 3.3V or 5V rails with high $\pm 35\text{kV}$ ESD performance and up to 42Mbps data rate. The device is optimized for high speeds over extended cable runs while maximizing tolerance to noise.

The MAX14783E is available in 8-pin $\mu\text{MAX}^{\text{®}}$, 8-pin SO, and 8-pin TDFN-EP packages. The device in the TDFN-EP package operates over the -40°C to $+125^{\circ}\text{C}$ temperature range. The MAX14783E in the μMAX and SO packages operates over the -40°C to $+85^{\circ}\text{C}$ and -40°C to $+125^{\circ}\text{C}$ temperature ranges.

Applications

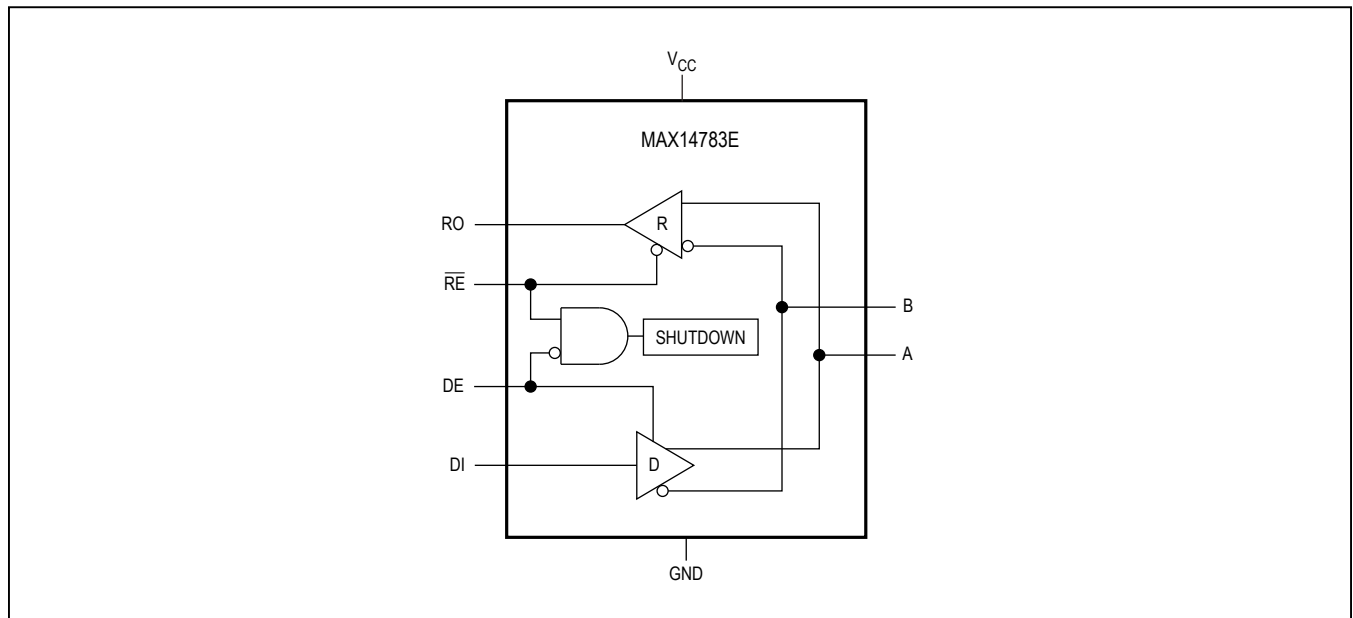
- Motion Controllers
- Field Bus Networks
- Encoder Interfaces
- Backplane Busses

Benefits and Features

- Integrated Protection Increases Robustness
 - High ESD Protection
 - $\pm 35\text{kV}$ HBM ESD per JEDEC JS-001-2012
 - $\pm 20\text{kV}$ Air Gap per IEC 61000-4-2
 - $\pm 12\text{kV}$ Contact ESD per IEC 61000-4-2
 - Short-Circuit Protected Outputs
 - True Fail-Safe Receiver Prevents False Transition on Receiver Input Short or Open Events
 - Hot-Swap Capability Eliminates False Transitions During Power-Up or Hot Insertion
- 3V to 5.5V Supply Voltage Range
- High-Speed Data Rates up to 42Mbps
- -40°C to $+125^{\circ}\text{C}$ Operating Temperature
- Allows Up to 32 Transceivers on the Bus
- Low $10\mu\text{A}$ (max) Shutdown Current for Lower Power Consumption

Ordering Information appears at end of data sheet.

Functional Diagram



μMAX is a registered trademark of Maxim Integrated Products, Inc.,

Absolute Maximum Ratings

(Voltages referenced to GND.)

V_{CC}-0.3V to +6.0V
 RO-0.3V to (V_{CC} + 0.3V)
 RE, DE, DI-0.3V to +6.0V
 A, B (V_{CC} ≥ 3.6V)-8.0V to +13.0V
 A, B (V_{CC} < 3.6V)-9.0V to +13.0V
 Short-Circuit Duration (RO, A, B) to GNDContinuous
 Operating Temperature Range
 MAX14783EE_-40°C to +85°C
 MAX14783EA_-40°C to +125°C

Junction Temperature+150°C
 Storage Temperature Range-65°C to +150°C
 Continuous Power Dissipation (T_A = +70°C)
 μMAX (derate at 4.8mW/°C above +70°C)387mW
 SO (derate at 7.6mW/°C above +70°C)606mW
 TDFN-EP (derate at 24.4mW/°C above +70°C)1951mW
 Lead Temperature (soldering, 10s)+300°C
 Soldering Temperature (reflow)+260°C

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Package Thermal Characteristics (Note 1)

Junction-to-Case Thermal Resistance (θ_{JC})
 8-pin μMAX42°C/W
 8-pin SO38°C/W
 8-pin TDFN-EP8°C/W

Junction-to-Ambient Thermal Resistance (θ_{JA})
 8-pin μMAX206°C/W
 8-pin SO132°C/W
 8-pin TDFN-EP41°C/W

Note 1: Package thermal resistances were obtained using the method described in JEDEC specification JESD51-7, using a four-layer board. For detailed information on package thermal considerations, refer to www.maximintegrated.com/thermal-tutorial.

Electrical Characteristics

(V_{CC} = +3.0V to +5.5V, T_A = T_{MIN} to T_{MAX}, unless otherwise specified. Typical values are at V_{CC} = +5V and T_A = +25°C.) (Notes 2, 3)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|--|-------------------|--|------|---------------------|------|-------|
| POWER SUPPLY | | | | | | |
| Supply Voltage | V _{CC} | | 3.0 | | 5.5 | V |
| Supply Current | I _{CC} | DE = V _{CC} , RE = GND, no load | | 1.9 | 4 | mA |
| Shutdown Supply Current | I _{SHDN} | DE = GND, RE = V _{CC} | | | 10 | μA |
| DRIVER | | | | | | |
| Differential Driver Output | V _{OD} | V _{CC} = 4.5V, R _L = 54Ω, Figure 1 | 2.1 | | | V |
| | | V _{CC} = 3V, R _L = 100Ω, Figure 1 | 2.0 | | | |
| | | V _{CC} = 3V, R _L = 54Ω, Figure 1 | 1.5 | | | |
| Change in Magnitude of Differential Output Voltage | ΔV _{OD} | R _L = 54Ω or 100Ω, Figure 1 (Note 4) | -0.2 | 0 | +0.2 | V |
| Driver Common-Mode Output Voltage | V _{OC} | R _L = 54Ω or 100Ω, Figure 1 | | V _{CC} / 2 | 3 | V |
| Change in Magnitude of Common-Mode Voltage | ΔV _{OC} | R _L = 54Ω or 100Ω, Figure 1 (Note 4) | -0.2 | | +0.2 | V |
| Single-Ended Driver Output High | V _{OH} | A or B output, I _{A or B} = -20mA | 2.2 | | | V |
| Single-Ended Driver Output Low | V _{OL} | A or B output, I _{A or B} = 20mA | | | 0.8 | V |
| Differential Output Capacitance | C _{OD} | DE = RE = V _{CC} , f = 4MHz | | 12 | | pF |
| Driver Short-Circuit Output Current | I _{OST} | 0 ≤ V _{OUT} ≤ +12V, output low | | | 250 | mA |
| | | -7V ≤ V _{OUT} ≤ V _{CC} , output high | | | 250 | mA |

Electrical Characteristics (continued)

(V_{CC} = +3.0V to +5.5V, T_A = T_{MIN} to T_{MAX}, unless otherwise specified. Typical values are at V_{CC} = +5V and T_A = +25°C.) (Notes 2, 3)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|--|-------------------|---|------------------------|------|------|-------|
| RECEIVER | | | | | | |
| Input Current | I _{A, B} | DE = GND, V _{CC} = GND or +5.5V | V _{IN} = +12V | 400 | 1000 | μA |
| | | | V _{IN} = -7V | -800 | 300 | |
| Differential Input Capacitance | C _{A, B} | Between A and B, DE = GND, f = 4MHz | | 12 | | pF |
| Receiver Differential Threshold Voltage | V _{TH} | -7V ≤ V _{CM} ≤ +12V | -200 | -105 | -10 | mV |
| Receiver Input Hysteresis | ΔV _{TH} | V _{CM} = 0V | | 10 | | mV |
| Receiver Input Resistance | R _{IN} | -7V ≤ V _{CM} ≤ +12V | 12 | | | kΩ |
| LOGIC INTERFACE (DI, DE, $\overline{\text{RE}}$, RO) | | | | | | |
| Input Voltage High | V _{IH} | DE, DI, $\overline{\text{RE}}$ | 2.0 | | | V |
| Input Voltage Low | V _{IL} | DE, DI, $\overline{\text{RE}}$ | | | 0.8 | V |
| Input Hysteresis | V _{HYS} | DE, DI, $\overline{\text{RE}}$ | | 50 | | mV |
| Input Current | I _{IN} | DE, DI, $\overline{\text{RE}}$ | | | ±1 | μA |
| Input Impedance on First Transition | | DE, $\overline{\text{RE}}$ | 1 | | 10 | kΩ |
| RO Output Voltage High | V _{OHRO} | $\overline{\text{RE}}$ = GND, I _{RO} = -2mA, (V _A - V _B) > 200mV | V _{CC} - 1.5 | | | V |
| RO Output Voltage Low | V _{OLRO} | $\overline{\text{RE}}$ = GND, I _{RO} = 2mA, (V _A - V _B) < -200mV | | | 0.4 | V |
| Receiver Tri-State Output Current | I _{OZR} | $\overline{\text{RE}}$ = V _{CC} , 0 ≤ V _{RO} ≤ V _{CC} | | | ±1 | μA |
| Receiver Output Short-Circuit Current | I _{OSR} | 0 ≤ V _{RO} ≤ V _{CC} | | | ±110 | mA |
| PROTECTION | | | | | | |
| Thermal Shutdown Threshold | T _{SHDN} | Temperature rising | | +160 | | °C |
| Thermal Shutdown Hysteresis | | | | 15 | | °C |
| ESD Protection on A and B Pins | | IEC 61000-4-2 Air Gap Discharge to GND | | ±20 | | kV |
| | | IEC 61000-4-2 Contact Discharge to GND | | ±12 | | |
| | | Human Body Model | | ±35 | | |
| ESD Protection, All Other Pins | | Human Body Model | | ±2 | | kV |

Switching Characteristics MAX14783E

(V_{CC} = +3V to +5.5V, T_A = T_{MIN} to T_{MAX}, unless otherwise specified. Typical values are at V_{CC} = +5V and T_A = +25°C.) (Notes 2, 3, 5)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS | |
|---|-----------------------------------|---|----------------------------------|-----|-----|-------|------|
| DRIVER | | | | | | | |
| Driver Propagation Delay | t _{DPLH} | R _L = 54Ω, C _L = 50pF, Figures 2 and 3 | | | 20 | ns | |
| | t _{DPHL} | | | | 20 | | |
| Driver Differential Output Rise or Fall Time | t _{HL} , t _{LH} | R _L = 54Ω, C _L = 50pF, Figures 2 and 3 | | | 7 | ns | |
| Differential Driver Output Skew t _{DPLH} - t _{DPHL} | t _{DSKEW} | R _L = 54Ω, C _L = 50pF, Figures 2 and 3 (Note 6) | | | 3 | ns | |
| Maximum Data Rate | DR _{MAX} | MAX14783EATA | | | | 42 | Mbps |
| | | MAX14783EEUA | | | | 30 | |
| | | MAX14783EESA | | | | 40 | |
| | | MAX14783EAUA | 3.0V ≤ V _{CC} ≤ 3.6V | | | 42 | |
| | | | 3.0V ≤ V _{CC} ≤ 5.5V | | | 6 | |
| | | MAX14783EASA | 3.0V ≤ V _{CC} ≤ 3.6V | | | 42 | |
| 3.0V ≤ V _{CC} ≤ 5.5V | | | 16 | | | | |
| Driver Enable to Output High | t _{DZH} | R _L = 110Ω, C _L = 50pF, Figures 4 and 5 (Note 7) | | | 30 | ns | |
| Driver Enable to Output Low | t _{DZL} | R _L = 110Ω, C _L = 50pF, Figures 4 and 5 (Note 7) | | | 30 | ns | |
| Driver Disable Time from Low | t _{DLZ} | R _L = 110Ω, C _L = 50pF, Figures 4 and 5 | | | 30 | ns | |
| Driver Disable Time from High | t _{DHZ} | R _L = 110Ω, C _L = 50pF, Figures 4 and 5 | | | 30 | ns | |
| Driver Enable from Shutdown to Output High | t _{DLZ(SHDN)} | R _L = 110Ω, C _L = 15pF, Figures 4 and 5 (Note 7) | | | 6 | μs | |

Switching Characteristics MAX14783E (continued)

(V_{CC} = +3V to +5.5V, T_A = T_{MIN} to T_{MAX}, unless otherwise specified. Typical values are at V_{CC} = +5V and T_A = +25°C.) (Notes 2, 3, 5)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|--|------------------------|--|-----|-----|-----|-------|
| Driver Enable from Shutdown to Output Low | t _{DHZ(SHDN)} | R _L = 110Ω, C _L = 15pF, Figures 4 and 5 (Note 7) | | | 6 | μs |
| Time to Shutdown | t _{SHDN} | (Note 7) | 50 | | 800 | ns |
| RECEIVER | | | | | | |
| Receiver Propagation Delay | t _{RPLH} | C _L = 15pF, Figures 6 and 7 | | | 25 | ns |
| | t _{RPHL} | | | | 25 | |
| Receiver Output Skew | t _{RSKEW} | C _L = 15pF, Figures 6 and 7 (Note 6) | | | 2 | ns |
| Maximum Data Rate | DR _{MAX} | | 42 | | | Mbps |
| Receiver Enable to Output High | t _{RZH} | R _L = 1kΩ, C _L = 15pF, Figure 8 (Note 7) | | | 30 | ns |
| Receiver Enable to Output Low | t _{RZL} | R _L = 1kΩ, C _L = 15pF, Figure 8 (Note 7) | | | 30 | ns |
| Receiver Disable Time from Low | t _{RLZ} | R _L = 1kΩ, C _L = 15pF, Figure 8 | | | 30 | ns |
| Receiver Disable Time from High | t _{RHZ} | R _L = 1kΩ, C _L = 15pF, Figure 8 | | | 30 | ns |
| Receiver Enable from Shutdown to Output High | t _{RLZ(SHDN)} | R _L = 1kΩ, C _L = 15pF, Figure 8 (Note 7) | | | 6 | μs |
| Receiver Enable from Shutdown to Output Low | t _{RHZ(SHDN)} | R _L = 1kΩ, C _L = 15pF, Figure 8 (Note 7) | | | 6 | μs |
| Time to Shutdown | t _{SHDN} | (Note 7) | 50 | | 800 | ns |

Note 2: All devices 100% production tested at T_A = +25°C. Specifications over temperature are guaranteed by design.**Note 3:** All currents into the device are positive; all currents out of the device are negative. All voltages are referenced to ground, unless otherwise noted.**Note 4:** ΔV_{OD} and ΔV_{OC} are the changes in V_{OD} and V_{OC}, respectively, when the DI input changes state.**Note 5:** Capacitive load includes test probe and fixture capacitance.**Note 6:** Guaranteed by design; not production tested.**Note 7:** The timing parameter refers to the driver or receiver enable delay, when the device has exited the initial hot-swap protect state and is in normal operating mode.**Note 8:** Shutdown is enabled by driving RE high and DE low. The device is guaranteed to have entered shutdown after t_{SHDN} has elapsed.

Test and Timing Diagrams



Figure 1. Driver DC Test Load



Figure 2. Driver Timing Test Circuit



Figure 3. Driver Propagation Delays



Figure 4. Driver Enable and Disable Times (t_{DZH} , t_{DHZ})

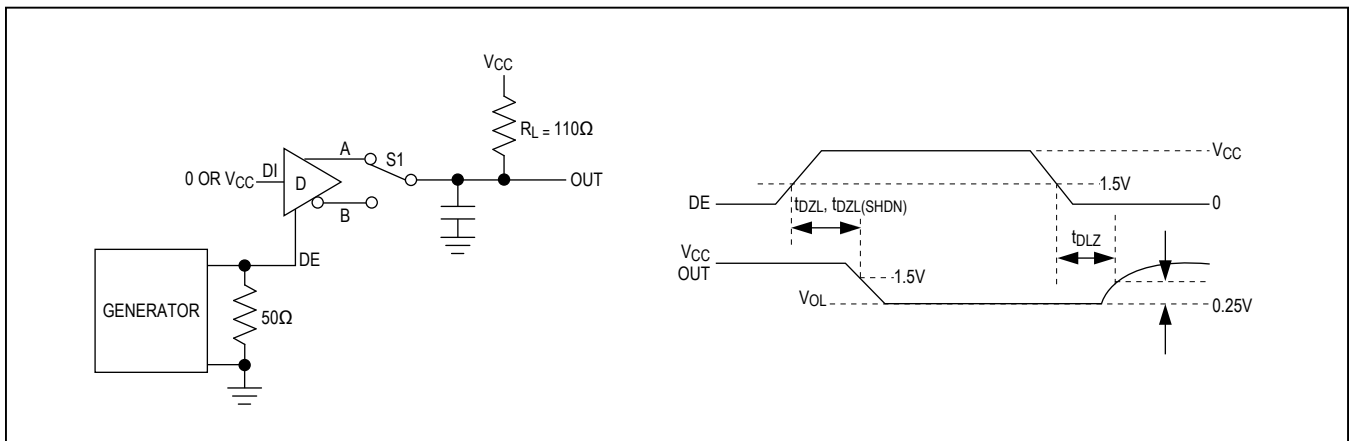


Figure 5. Driver Enable and Disable Times (t_{DZL} , t_{DLZ})

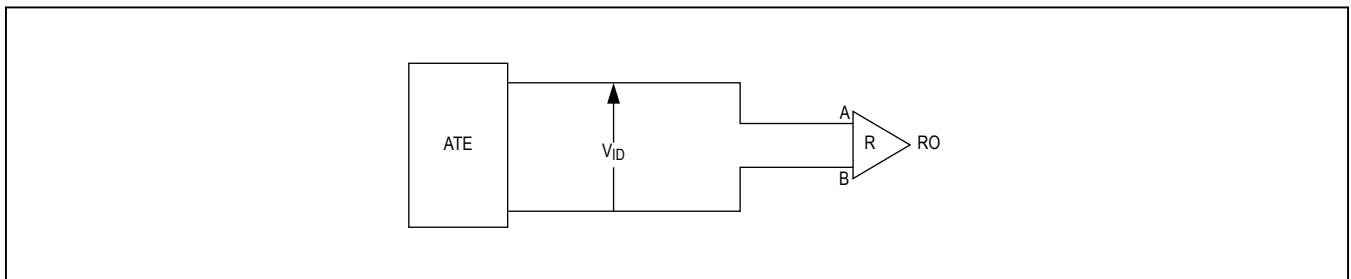


Figure 6. Receiver Propagation Delay Test Circuit



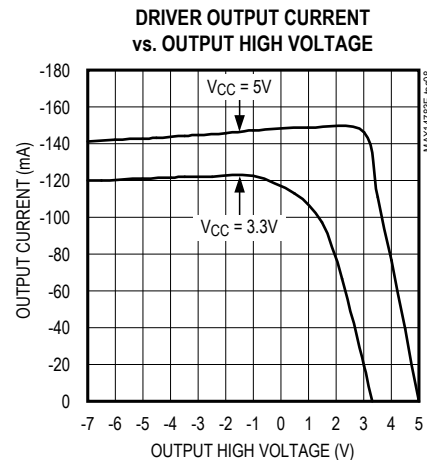
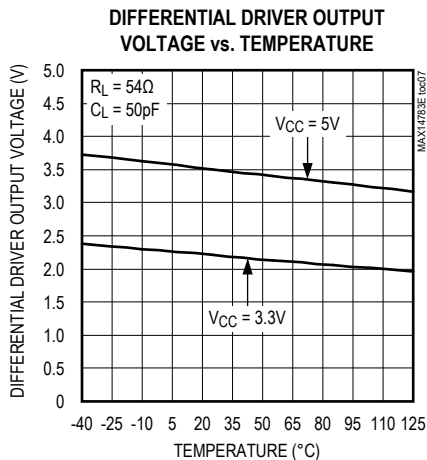
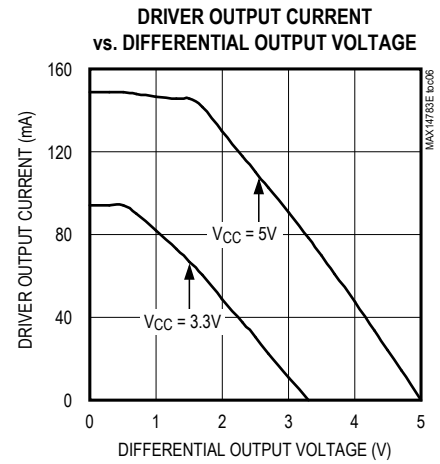
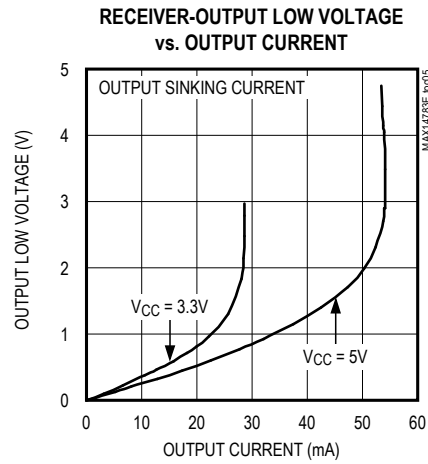
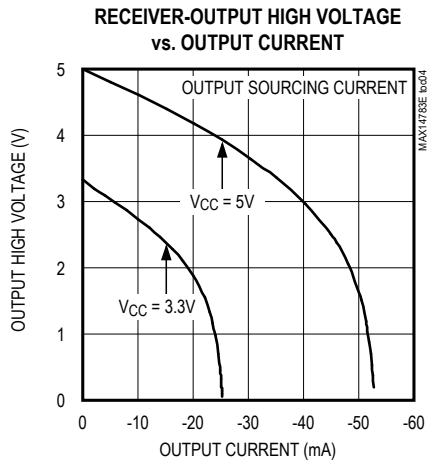
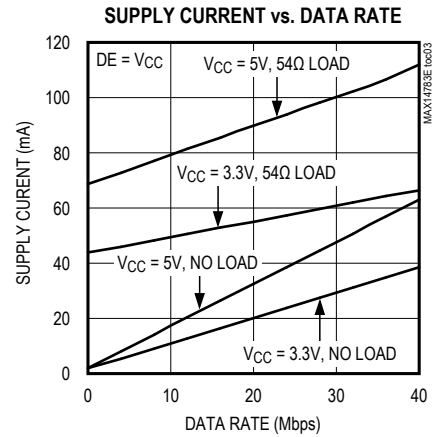
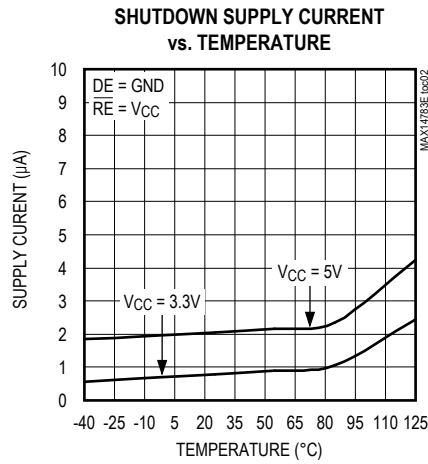
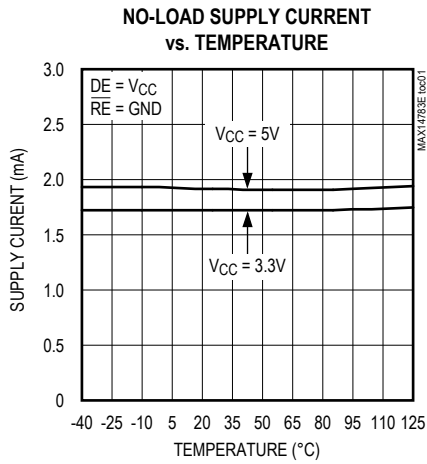
Figure 7. Receiver Propagation Delays



Figure 8. Receiver Enable and Disable Times

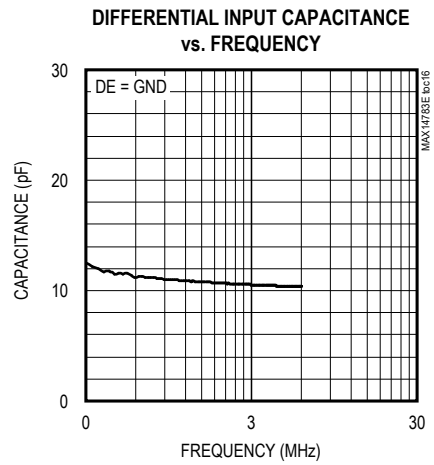
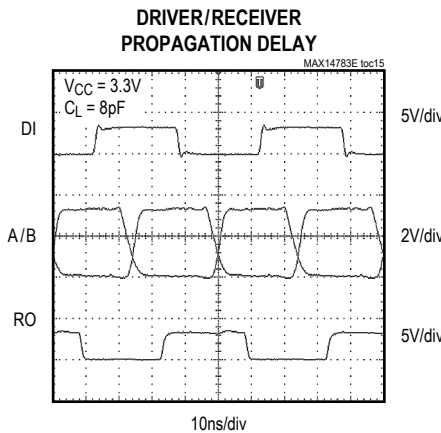
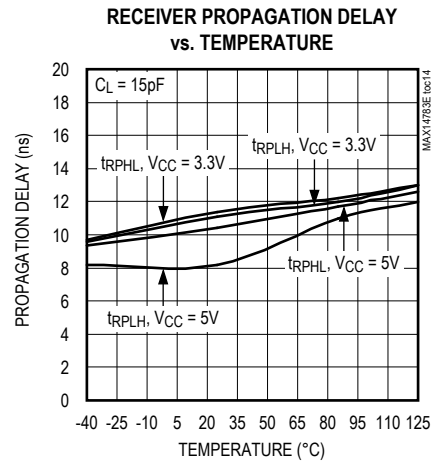
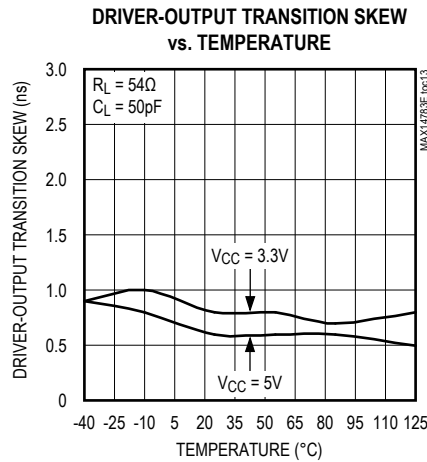
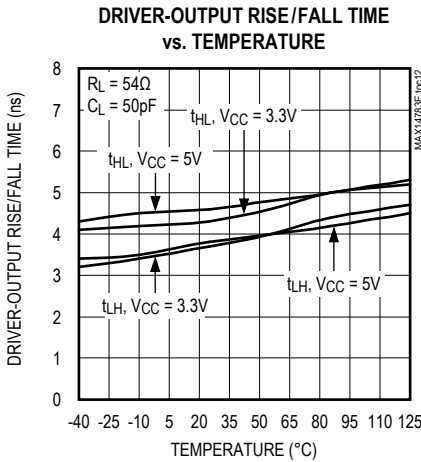
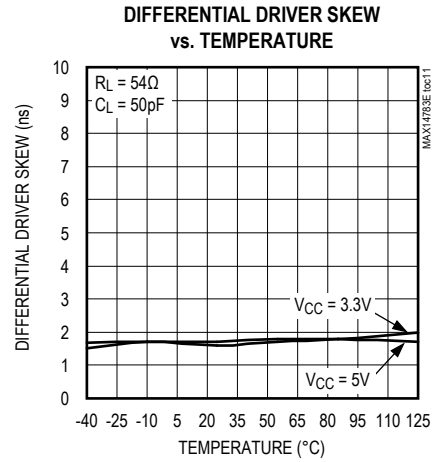
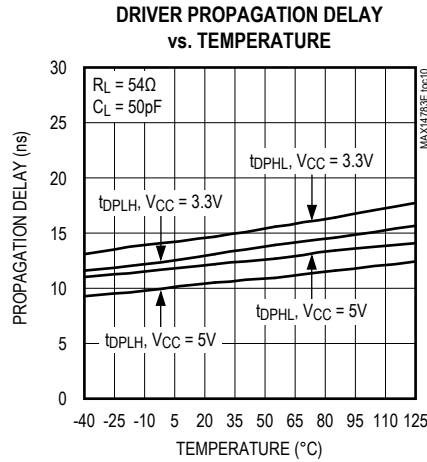
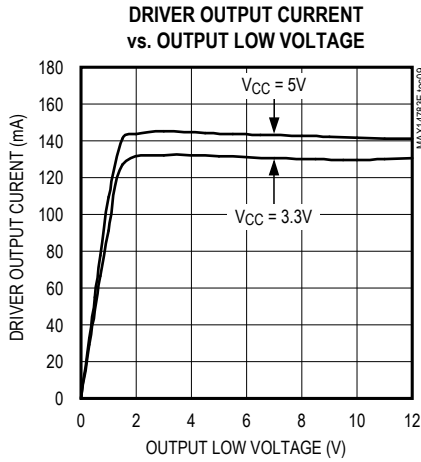
Typical Operating Characteristics

($V_{CC} = +5\text{V}$, $T_A = +25^\circ\text{C}$, unless otherwise specified.)

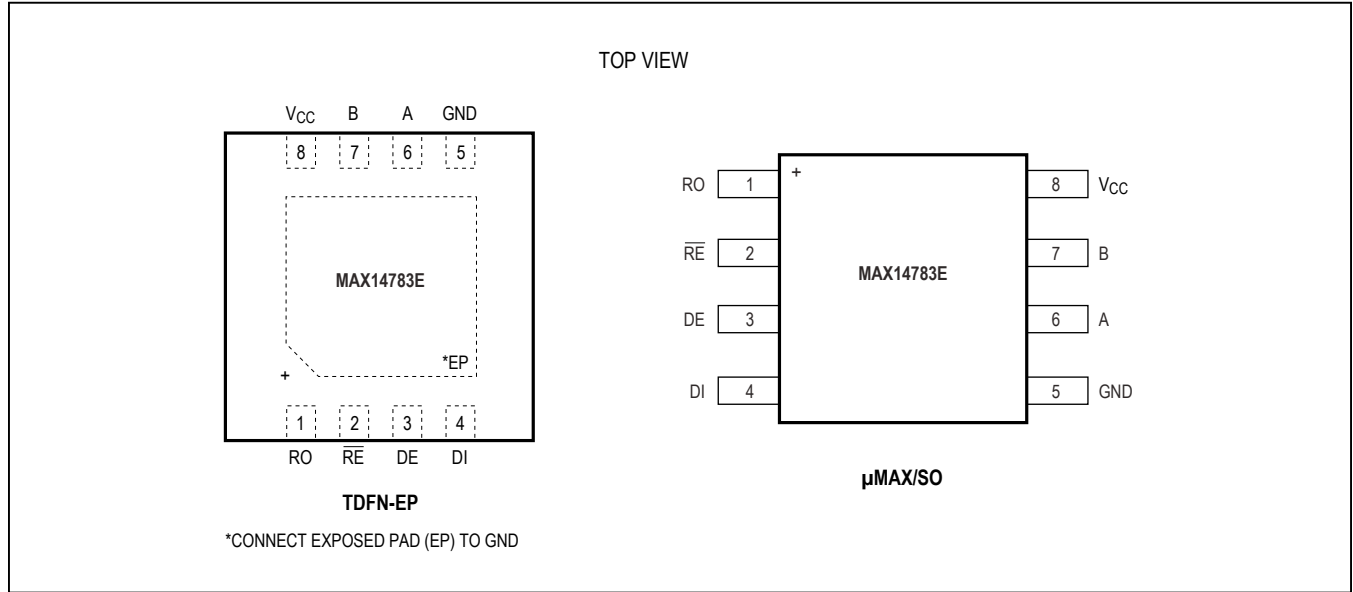


Typical Operating Characteristics (continued)

(V_{CC} = +5V, T_A = +25°C, unless otherwise specified.)



Pin Configuration



Pin Description

| PIN | NAME | FUNCTION |
|-----|-----------------|---|
| 1 | RO | Receiver Output. See <i>Function Tables</i> . |
| 2 | \overline{RE} | Receiver Output Enable. Drive \overline{RE} low to enable RO. Drive \overline{RE} high to disable the receiver. RO is high impedance when \overline{RE} is high. Drive \overline{RE} high and pull DE low to enter low-power shutdown mode. |
| 3 | DE | Driver Output Enable. Drive DE high to enable the driver. Drive DE low to disable the driver. Driver outputs are high-impedance when the driver is disabled. Drive \overline{RE} high and pull DE low to enter low-power shutdown mode. |
| 4 | DI | Driver Input. With DE high, a low on DI forces the A output low and the B output high. Similarly, a high on DI forces the A output high and B output low. |
| 5 | GND | Ground |
| 6 | A | Noninverting RS-485/RS-422 Receiver Input and Driver Output |
| 7 | B | Inverting RS-485/RS-422 Receiver Input and Driver Output |
| 8 | V _{CC} | Positive Supply Voltage Input. Bypass V _{CC} with a 0.1μF ceramic capacitor to ground. |
| — | EP | Exposed Pad (TDFN only). Connect EP to GND. |

Function Tables

| TRANSMITTING | | | | | |
|------------------------|----|----|----------------|---|-----------------|
| INPUTS | | | OUTPUTS | | MODE |
| $\overline{\text{RE}}$ | DE | DI | B | A | |
| X | 1 | 1 | 0 | 1 | Active |
| X | 1 | 0 | 1 | 0 | Active |
| 0 | 0 | X | High Impedance | | Driver Disabled |
| 1 | 0 | X | High Impedance | | Shutdown |

| RECEIVING | | | | | |
|------------------------|----|----------------------|----------------|--------|-------------------|
| INPUTS | | | OUTPUTS | MODE | |
| $\overline{\text{RE}}$ | DE | A-B | RO | | |
| 0 | X | $\geq -10\text{mV}$ | 1 | Active | |
| 0 | X | $\leq -200\text{mV}$ | 0 | Active | |
| 0 | X | Open/Shorted | 1 | Active | |
| 1 | 1 | X | High Impedance | | Receiver Disabled |
| 1 | 0 | X | High Impedance | | Shutdown |

X = Don't care

Detailed Description

The MAX14783E is a 3.3V/5V ESD-protected RS-485/RS-422 transceiver intended for high-speed, half-duplex communications. Integrated hot-swap functionality eliminates false transitions on the bus during power-up or hot insertion.

The device features fail-safe receiver inputs guaranteeing a logic-high receiver output when inputs are shorted or open. The IC has a 1-unit load receiver input impedance, allowing up to 32 transceivers on the bus.

True Fail Safe

The MAX14783E guarantees a logic-high receiver output when the receiver inputs are shorted or open, or when they are connected to a terminated transmission line with all drivers disabled. If the differential receiver input voltage (A-B) is greater than or equal to -10mV , RO is logic-high.

Driver Single-Ended Operation

The A and B outputs can either be used in the standard differential operating mode, or can be used as single-ended outputs. Since the A and B driver outputs swing rail-to-rail, they can individually be used as standard TTL logic outputs.

Hot-Swap Capability

Hot-Swap Inputs

When circuit boards are inserted in a hot or powered backplane, disturbances on the enable inputs and differential receiver inputs can lead to data errors. Upon initial circuit board insertion, the processor undergoes its power-up sequence. During this period, the processor output drivers are high impedance and are unable to drive the DE and RE inputs of the MAX14783E to a defined logic level. Leakage currents up to $10\mu\text{A}$ from the high-impedance outputs of a controller could cause DE and RE to drift to an incorrect logic state. Additionally, parasitic circuit board capacitance could cause coupling of V_{CC} or GND to DE and RE. These factors could improperly enable the driver or receiver. The MAX14783E features integrated hot-swap inputs that help to avoid these potential problems.

When V_{CC} rises, an internal pulldown circuit holds DE low and RE high. After the initial power-up sequence, the pulldown circuit becomes transparent, resetting the hot-swap-tolerable inputs.

Hot-Swap Input Circuitry

The DE and RE enable inputs feature hot-swap capability. At the input, there are two nMOS devices, M1 and M2 (Figure 9). When V_{CC} ramps from 0V, an internal $10\mu\text{s}$ timer turns on M2 and sets the SR latch that also turns



Figure 9. Simplified Structure of the Driver Enable (DE) Pin

on M1. Transistors M2 (a 500µA current sink) and M1 (a 100µA current sink) pull DE to GND through a 5kΩ (typ) resistor. M2 is designed to pull DE to the disabled state against an external parasitic capacitance up to 100pF that can drive DE high. After 10µs, the timer deactivates M2 while M1 remains on, holding DE low against three-state leakages that can drive DE high. M1 remains on until an external source overcomes the required input current. At this time, the SR latch resets and M1 turns off. When M1 turns off, DE reverts to a standard, high-impedance CMOS input. Whenever V_{CC} drops below 1V, the hot-swap input is reset.

A complementary circuit employing two pMOS devices pulls RE to V_{CC}.

±35kV ESD Protection

ESD protection structures are incorporated on all pins to protect against electrostatic discharges encountered during handling and assembly. The driver outputs and receiver inputs of the MAX14783E have extra protection against static electricity. The ESD structures withstand high ESD in all states: normal operation, shutdown, and powered down. After an ESD event, the MAX14783E keeps working without latch-up or damage.

ESD protection can be tested in various ways. The transmitter outputs and receiver inputs of the MAX14783E are characterized for protection to the following limits:

- ±35kV HBM
- ±20kV using the Air-Gap Discharge method specified in IEC 61000-4-2
- ±12kV using the Contact Discharge method specified in IEC 61000-4-2

ESD Test Conditions

ESD performance depends on a variety of conditions. Contact Maxim for a reliability report that documents test setup, test methodology, and test results.

Human Body Model (HBM)

Figure 10 shows the HBM, and Figure 11 shows the current waveform it generates when discharged into a low-impedance state. This model consists of a 100pF capacitor charged to the ESD voltage of interest, which is then discharged into the test device through a 1.5kΩ resistor.

IEC 61000-4-2

The IEC 61000-4-2 standard covers ESD testing and performance of finished equipment. However, it does not specifically refer to integrated circuits. The MAX14783E helps in designing equipment to meet IEC 61000-4-2 without the need for additional ESD protection components.

The major difference between tests done using the HBM and IEC 61000-4-2 is higher peak current in IEC 61000-4-2 because series resistance is lower in the IEC 61000-4-2 model. Hence, the ESD withstand voltage measured to IEC 61000-4-2 is generally lower than that measured using the HBM.

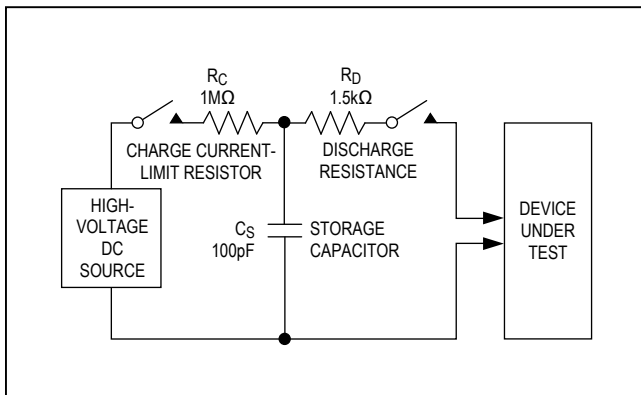


Figure 10. Human Body ESD Test Model

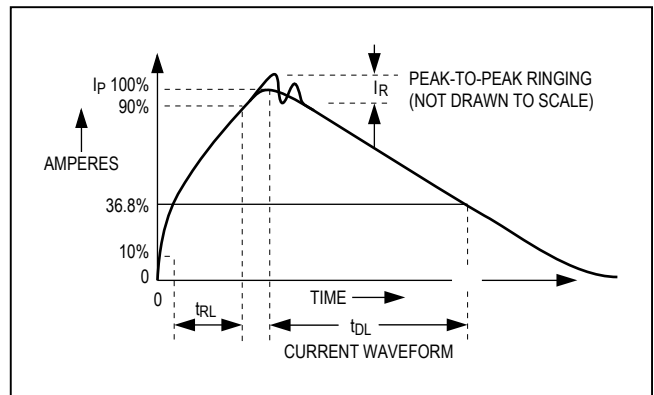


Figure 11. Human Body Current Waveform

Figure 12 shows the IEC 61000-4-2 model, and Figure 13 shows the current waveform for IEC 61000-4-2 ESD Contact Discharge test.

Applications Information

Driver Output Protection

Two mechanisms prevent excessive output current and power dissipation caused by faults or by bus connection. The first, a current limit on the output stage provides immediate protection against short circuits over the whole common-mode voltage range. The second, a thermal-shutdown circuit, forces the driver outputs into a high-impedance state if the die temperature exceeds $+160^\circ\text{C}$ (typ).

Low-Power Shutdown Mode

Low-power shutdown mode is initiated by bringing $\overline{\text{RE}}$ high and DE low. In shutdown, the devices draw less than $10\mu\text{A}$ of supply current.

$\overline{\text{RE}}$ and DE can be connected together and driven simultaneously. The MAX14783E is guaranteed not to enter shutdown if $\overline{\text{RE}}$ is high and DE is low for less than 50ns. If the inputs are in this state for at least 800ns (max), the device is guaranteed to enter shutdown.

Typical Applications

The MAX14783E transceiver is designed for bidirectional data communications on multipoint bus transmission lines. Figure 14 shows a typical network application circuit. To minimize reflections, terminate the line at both ends with its characteristic impedance and keep stub lengths off the main line as short as possible.



Figure 12. IEC 61000-4-2 ESD Test Model

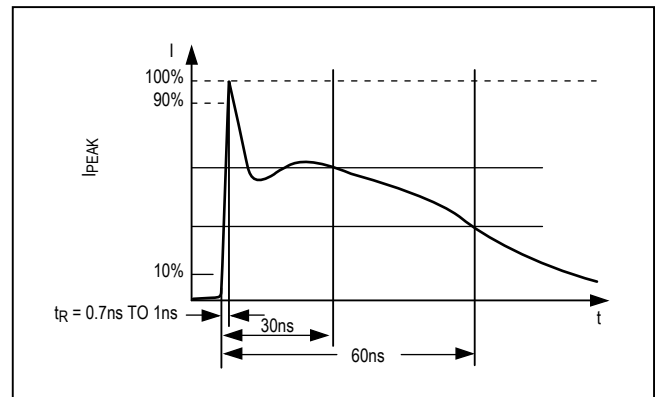


Figure 13. IEC 61000-4-2 ESD Generator Current Waveform

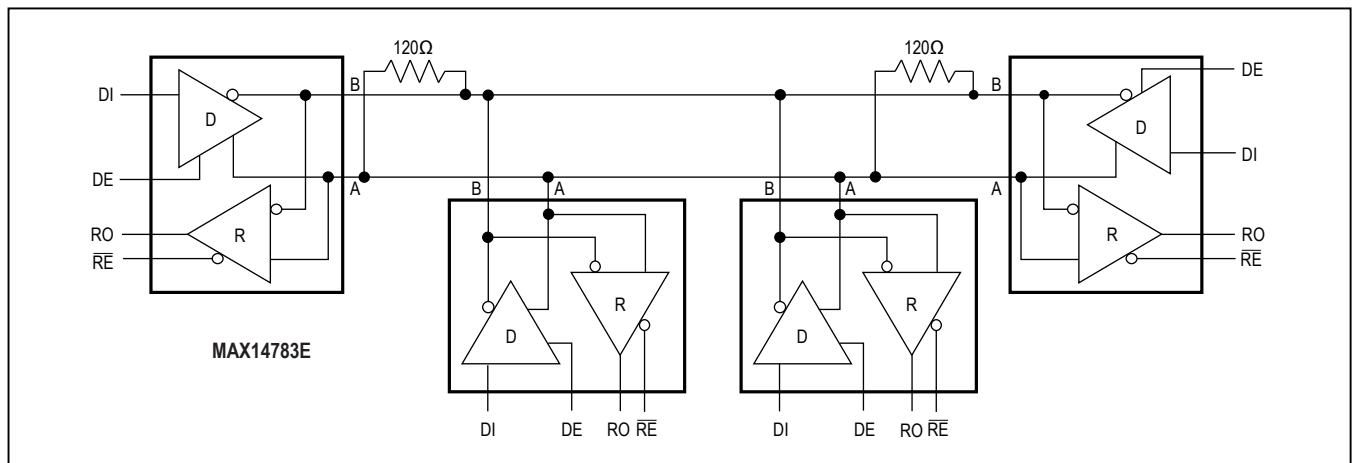


Figure 14. Typical Half-Duplex RS-485 Network

Chip Information

PROCESS: BiCMOS

Package Information

For the latest package outline information and land patterns (footprints), go to www.maximintegrated.com/packages. Note that a "+", "#", or "-" in the package code indicates RoHS status only. Package drawings may show a different suffix character, but the drawing pertains to the package regardless of RoHS status.

| PACKAGE TYPE | PACKAGE CODE | OUTLINE NO. | LAND PATTERN NO. |
|--------------|--------------|-------------------------|-------------------------|
| 8 μ MAX | U8+1 | 21-0036 | 90-0092 |
| 8 SOIC | S8+4 | 21-0041 | 90-0096 |
| 8 TDFN-EP | T833+2 | 21-0137 | 90-0059 |

Ordering Information

| PART | SUPPLY RANGE | DATA RATE (MAX) | TEMP RANGE | PIN-PACKAGE |
|---------------|--------------|-----------------|-----------------|-------------|
| MAX14783EEUA+ | 3.0V to 5.5V | 30Mbps | -40°C to +85°C | 8 μ MAX |
| MAX14783EESA+ | 3.0V to 5.5V | 40Mbps | -40°C to +85°C | 8 SO |
| MAX14783EATA+ | 3.0V to 5.5V | 42Mbps | -40°C to +125°C | 8 TDFN-EP* |
| MAX14783EASA+ | 3.0V to 3.6V | 42Mbps | -40°C to +125°C | 8 SO |
| | 3.0V to 5.5V | 16Mbps | | |
| MAX14783EAUA+ | 3.0V to 3.6V | 42Mbps | -40°C to +125°C | 8 μ MAX |
| | 3.0V to 5.5V | 6Mbps | | |

+Denotes lead(Pb)-free/RoHS-compliant package.

*EP = Exposed paddle.

Revision History

| REVISION NUMBER | REVISION DATE | DESCRIPTION | PAGES CHANGED |
|-----------------|---------------|------------------------|---------------|
| 0 | 6/13 | Initial release | — |
| 1 | 1/15 | Updated page 1 content | |

For pricing, delivery, and ordering information, please contact Maxim Direct at 1-888-629-4642, or visit Maxim Integrated's website at www.maximintegrated.com.

Maxim Integrated cannot assume responsibility for use of any circuitry other than circuitry entirely embodied in a Maxim Integrated product. No circuit patent licenses are implied. Maxim Integrated reserves the right to change the circuitry and specifications without notice at any time. The parametric values (min and max limits) shown in the Electrical Characteristics table are guaranteed. Other parametric values quoted in this data sheet are provided for guidance.

Компания «Life Electronics» занимается поставками электронных компонентов импортного и отечественного производства от производителей и со складов крупных дистрибьюторов Европы, Америки и Азии.

С конца 2013 года компания активно расширяет линейку поставок компонентов по направлению коаксиальный кабель, кварцевые генераторы и конденсаторы (керамические, пленочные, электролитические), за счёт заключения дистрибьюторских договоров

Мы предлагаем:

- Конкурентоспособные цены и скидки постоянным клиентам.
- Специальные условия для постоянных клиентов.
- Подбор аналогов.
- Поставку компонентов в любых объемах, удовлетворяющих вашим потребностям.
- Приемлемые сроки поставки, возможна ускоренная поставка.
- Доставку товара в любую точку России и стран СНГ.
- Комплексную поставку.
- Работу по проектам и поставку образцов.
- Формирование склада под заказчика.
- Сертификаты соответствия на поставляемую продукцию (по желанию клиента).
- Тестирование поставляемой продукции.
- Поставку компонентов, требующих военную и космическую приемку.
- Входной контроль качества.
- Наличие сертификата ISO.

В составе нашей компании организован Конструкторский отдел, призванный помогать разработчикам, и инженерам.

Конструкторский отдел помогает осуществить:

- Регистрацию проекта у производителя компонентов.
- Техническую поддержку проекта.
- Защиту от снятия компонента с производства.
- Оценку стоимости проекта по компонентам.
- Изготовление тестовой платы монтаж и пусконаладочные работы.



Тел: +7 (812) 336 43 04 (многоканальный)
Email: org@lifeelectronics.ru